

Notice of References Cited	Application/Control No. 10/571,195		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Patricia Leith		Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,378,466	01-1995	Endo, Koichi	424/728
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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